



3.3V CMOS REGISTERED ADDRESS LINE DRIVER WITH 3-STATE OUTPUTS AND BUS-HOLD

IDT74ALVCH16345

FEATURES:

- 0.5 MICRON CMOS Technology
- Typical $t_{sk(o)}$ (Output Skew) < 250ps
- ESD > 2000V per MIL-STD-883, Method 3015; > 200V using machine model (C = 200pF, R = 0)
- V_{CC} = 3.3V ± 0.3V, Normal Range
- V_{CC} = 2.7V to 3.6V, Extended Range
- V_{CC} = 2.5V ± 0.2V
- CMOS power levels (0.4µW typ. static)
- Rail-to-Rail output swing for increased noise margin
- Available in TSSOP package

DRIVE FEATURES:

- High Output Drivers: ±24mA
- Suitable for heavy loads

APPLICATIONS:

- 3.3V high speed systems
- 3.3V and lower voltage computing systems
- High speed synchronous DRAM modules
- PC motherboards

DESCRIPTION:

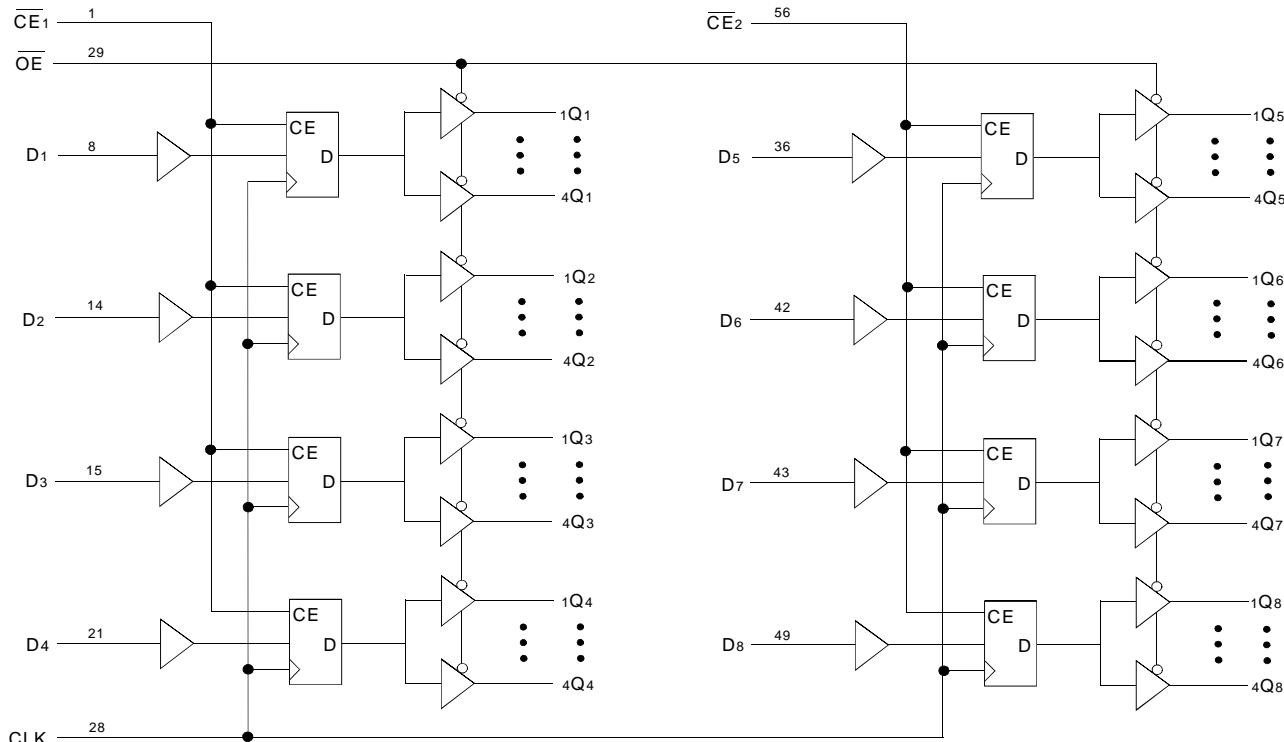
This registered address line driver is built using advanced dual metal CMOS technology. The ALVCH16345 is configured with banks of four drivers, each to be used in high speed synchronous memory applications.

The ALVCH16345 is ideal for driving memory modules in systems where multiple memory modules are used. One each of the four output banks drives a different module; modules can be added or removed without affecting the signal integrity of the other modules in the system. Dual clock enables (\overline{CE}_X) allow use of the device in high speed memory interleaving applications where the clock can be alternately enabled and disabled, allowing the address to be held for additional cycles during memory access.

The ALVCH16345 has been designed with a ±24mA output driver. This driver is capable of driving a moderate to heavy load while maintaining speed performance.

The ALVCH16345 has "bus-hold" which retains the inputs' last state whenever the input goes to a high impedance. This prevents floating inputs and eliminates the need for pull-up/down resistors.

FUNCTIONAL BLOCK DIAGRAM

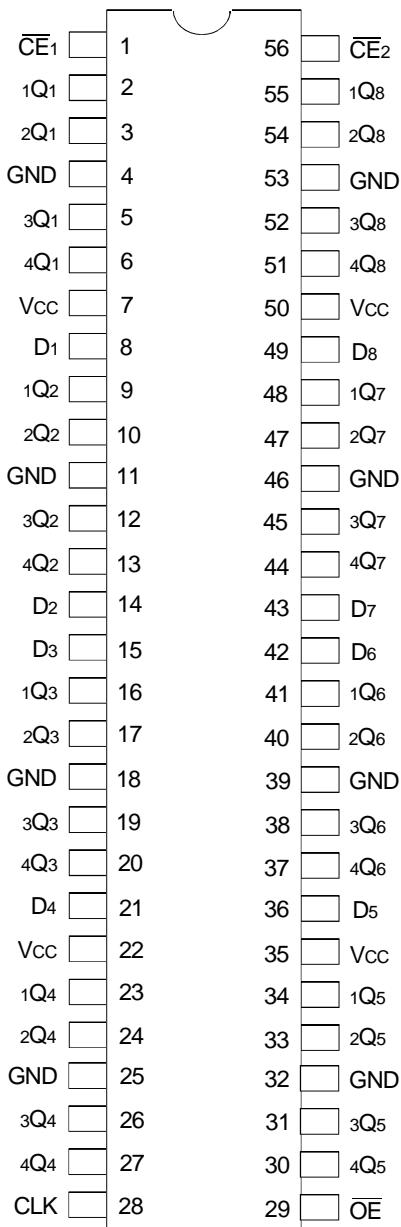


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INDUSTRIAL TEMPERATURE RANGE

JANUARY 2004

PIN CONFIGURATION

TSSOP
TOP VIEW

PIN DESCRIPTION

Pin Names	Description
OE	3-State Output Enable Inputs (Active LOW)
Dx	Data Inputs ⁽¹⁾
xQx	3-State Data Outputs
CLK	Clock Input
CEx	Clock Enable Inputs (Active LOW)

NOTE:

1. These pins have "Bus-Hold". All other pins are standard inputs, outputs, or I/Os.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Description	Max	Unit
VTERM ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +4.6	V
VTERM ⁽³⁾	Terminal Voltage with Respect to GND	-0.5 to Vcc+0.5	V
TSTG	Storage Temperature	-65 to +150	°C
IOUT	DC Output Current	-50 to +50	mA
Ik	Continuous Clamp Current, Vi < 0 or Vi > Vcc	±50	mA
Ik	Continuous Clamp Current, Vo < 0	-50	mA
Icc	Continuous Current through each Vcc or GND	±100	mA
Iss			

NOTES:

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- Vcc terminals.
- All terminals except Vcc.

CAPACITANCE (TA = +25°C, F = 1.0MHz)

Symbol	Parameter ⁽¹⁾	Conditions	Typ.	Max.	Unit
CIN	Input Capacitance	VIN = 0V	5	7	pF
COUT	Output Capacitance	VOUT = 0V	7	9	pF
CIO	I/O Port Capacitance	VIN = 0V	7	9	pF

NOTE:

- As applicable to the device type.

FUNCTION TABLE⁽¹⁾

Inputs				Output
CEx	CLK	OE	Dx	xQx
H	X	L	X	B ²
X	L	L	X	B ²
L	↑	L	L	L
L	↑	L	H	H
X	X	H	X	Z

NOTES:

- H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care
Z = High-Impedance
↑ = LOW-to-HIGH Transition
- Output level before the indicated steady-state input conditions were established.

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

Operating Condition: TA = -40°C to +85°C

Symbol	Parameter	Test Conditions		Min.	Typ. ⁽¹⁾	Max.	Unit
VIH	Input HIGH Voltage Level	VCC = 2.3V to 2.7V		1.7	—	—	V
		VCC = 2.7V to 3.6V		2	—	—	
VIL	Input LOW Voltage Level	VCC = 2.3V to 2.7V		—	—	0.7	V
		VCC = 2.7V to 3.6V		—	—	0.8	
I _{IH}	Input HIGH Current	VCC = 3.6V	VI = VCC	—	—	±5	µA
I _{IL}	Input LOW Current	VCC = 3.6V	VI = GND	—	—	±5	µA
I _{OZH}	High Impedance Output Current (3-State Output pins)	VCC = 3.6V	VO = VCC	—	—	±10	µA
			VO = GND	—	—	±10	
V _{IK}	Clamp Diode Voltage	VCC = 2.3V, I _{IN} = -18mA		—	-0.7	-1.2	V
V _H	Input Hysteresis	VCC = 3.3V		—	100	—	mV
I _{CCL} I _{CCH} I _{CZZ}	Quiescent Power Supply Current	VCC = 3.6V VIN = GND or VCC		—	0.1	40	µA
ΔI _{CC}	Quiescent Power Supply Current Variation	One input at VCC - 0.6V, other inputs at VCC or GND		—	—	750	µA

NOTE:

1. Typical values are at VCC = 3.3V, +25°C ambient.

BUS-HOLD CHARACTERISTICS

Symbol	Parameter ⁽¹⁾	Test Conditions		Min.	Typ. ⁽²⁾	Max.	Unit
I _{BHH} I _{BHL}	Bus-Hold Input Sustain Current	VCC = 3V	VI = 2V	-75	—	—	µA
			VI = 0.8V	75	—	—	
I _{BHH} I _{BHL}	Bus-Hold Input Sustain Current	VCC = 2.3V	VI = 1.7V	-45	—	—	µA
			VI = 0.7V	45	—	—	
I _{BHHO} I _{BHLO}	Bus-Hold Input Overdrive Current	VCC = 3.6V	VI = 0 to 3.6V	—	—	±500	µA

NOTES:

1. Pins with Bus-Hold are identified in the pin description.

2. Typical values are at VCC = 3.3V, +25°C ambient.

OUTPUT DRIVE CHARACTERISTICS

Symbol	Parameter	Test Conditions ⁽¹⁾		Min.	Max.	Unit
VOH	Output HIGH Voltage	VCC = 2.3V to 3.6V	I _{OH} = -0.1mA	VCC - 0.2	—	V
		VCC = 2.3V	I _{OH} = -6mA	2	—	
		VCC = 2.3V	I _{OH} = -12mA	1.7	—	
		VCC = 2.7V		2.2	—	
		VCC = 3V	I _{OH} = -24mA	2.4	—	
		VCC = 3V		2	—	
VOL	Output LOW Voltage	VCC = 2.3V to 3.6V	I _{OL} = 0.1mA	—	0.2	V
		VCC = 2.3V	I _{OL} = 6mA	—	0.4	
			I _{OL} = 12mA	—	0.7	
		VCC = 2.7V	I _{OL} = 12mA	—	0.4	
		VCC = 3V	I _{OL} = 24mA	—	0.55	

NOTE:

1. V_{IH} and V_{IL} must be within the min. or max. range shown in the DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE table for the appropriate V_{CC} range.
TA = -40°C to +85°C.

OPERATING CHARACTERISTICS, TA = 25°C

Symbol	Parameter	Test Conditions	V _{CC} = 2.5V ± 0.2V	V _{CC} = 3.3V ± 0.3V	Unit
			Typical	Typical	
CPD	Power Dissipation Capacitance Outputs enabled	CL = 0pF, f = 10Mhz			pF
	Power Dissipation Capacitance Outputs disabled				

SWITCHING CHARACTERISTICS⁽¹⁾

Symbol	Parameter	V _{CC} = 2.5V ± 0.2V		V _{CC} = 2.7V		V _{CC} = 3.3V ± 0.3V		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
f _{MAX}		150	—	150	—	150	—	ns
t _{PLH}	Propagation Delay CLK to xQx	1.5	5.4	1.5	4.4	1.5	4	ns
t _{PHL}								
t _{PZH}	Output Enable Time OE to xQx	1.5	5.2	1.5	5.1	1.5	4.5	ns
t _{PZL}								
t _{PHZ}	Output Disable Time OE to xQx	1.5	5.5	1.5	4.5	1.5	5.2	ns
t _{PLZ}								
t _{SU}	Set-up Time, CEx to CLK, HIGH or LOW	1.5	—	1.5	—	1.5	—	ns
t _{SU}	Set-up Time, Dx to CLK, HIGH or LOW	1.5	—	1.5	—	1.5	—	ns
t _H	Hold Time, CEx to CLK, HIGH or LOW	0.5	—	0.5	—	0.5	—	ns
t _H	Hold Time, Dx to CLK, HIGH or LOW	0.5	—	0.5	—	0.5	—	ns
t _W	Pulse Width, CLK HIGH or LOW	3	—	3	—	3	—	ns
t _{sk(0)}	Output Skew ⁽²⁾	—	—	—	—	—	500	ps
t _{sk(b)}	Output Skew ⁽²⁾	—	—	—	—	—	350	ps

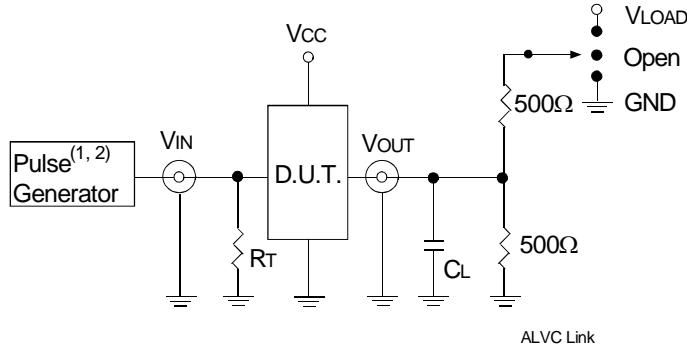
NOTES:

1. See TEST CIRCUITS AND WAVEFORMS. TA = -40°C to +85°C.
2. Skew between any two outputs of the same package and switching in the same direction. For t_{sk(0)} OUTPUT1 and OUTPUT2 are any two outputs. For t_{sk(b)} OUTPUT1 and OUTPUT2 are in the same bank.

TEST CIRCUITS AND WAVEFORMS

TEST CONDITIONS

Symbol	$V_{CC}^{(1)} = 3.3V \pm 0.3V$	$V_{CC}^{(1)} = 2.7V$	$V_{CC}^{(2)} = 2.5V \pm 0.2V$	Unit
V_{LOAD}	6	6	$2 \times V_{CC}$	V
V_{IH}	2.7	2.7	V_{CC}	V
V_T	1.5	1.5	$V_{CC} / 2$	V
V_{LZ}	300	300	150	mV
V_{HZ}	300	300	150	mV
C_L	50	50	30	pF



DEFINITIONS:

C_L = Load capacitance: includes jig and probe capacitance.

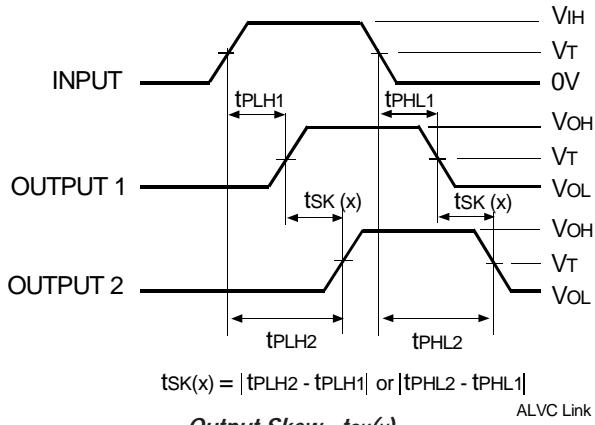
R_T = Termination resistance: should be equal to Z_{out} of the Pulse Generator.

NOTES:

1. Pulse Generator for All Pulses: Rate $\leq 1.0\text{MHz}$; $t_f \leq 2.5\text{ns}$; $t_r \leq 2.5\text{ns}$.
2. Pulse Generator for All Pulses: Rate $\leq 1.0\text{MHz}$; $t_f \leq 2\text{ns}$; $t_r \leq 2\text{ns}$.

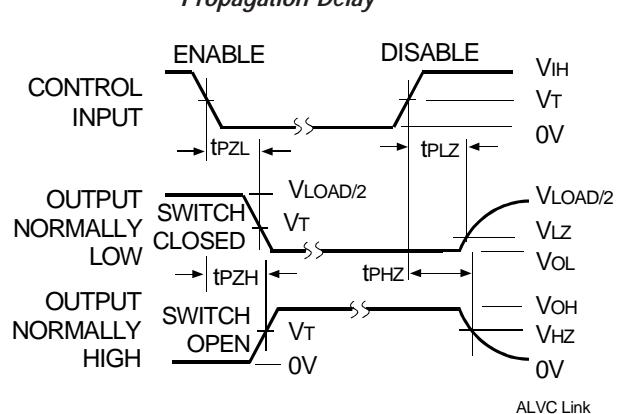
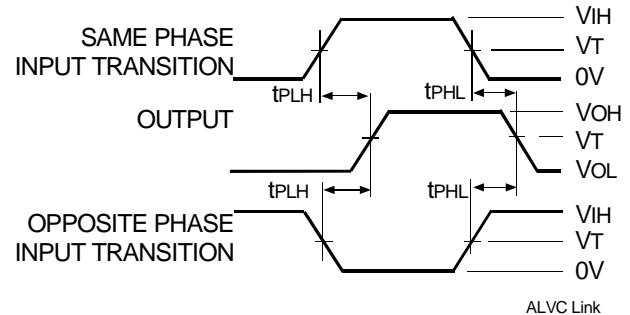
SWITCH POSITION

Test	Switch
Open Drain	
Disable Low	V_{LOAD}
Enable Low	
Disable High	GND
Enable High	
All Other Tests	Open



NOTES:

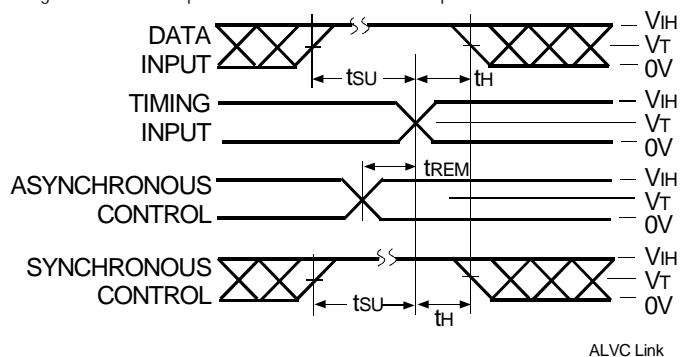
1. For $t_{SK}(o)$ OUTPUT1 and OUTPUT2 are any two outputs.
2. For $t_{SK}(b)$ OUTPUT1 and OUTPUT2 are in the same bank.



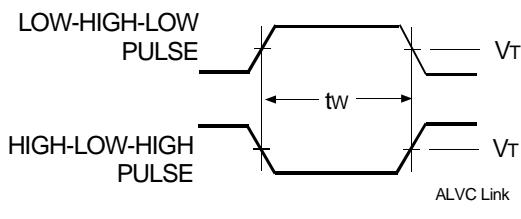
Enable and Disable Times

NOTE:

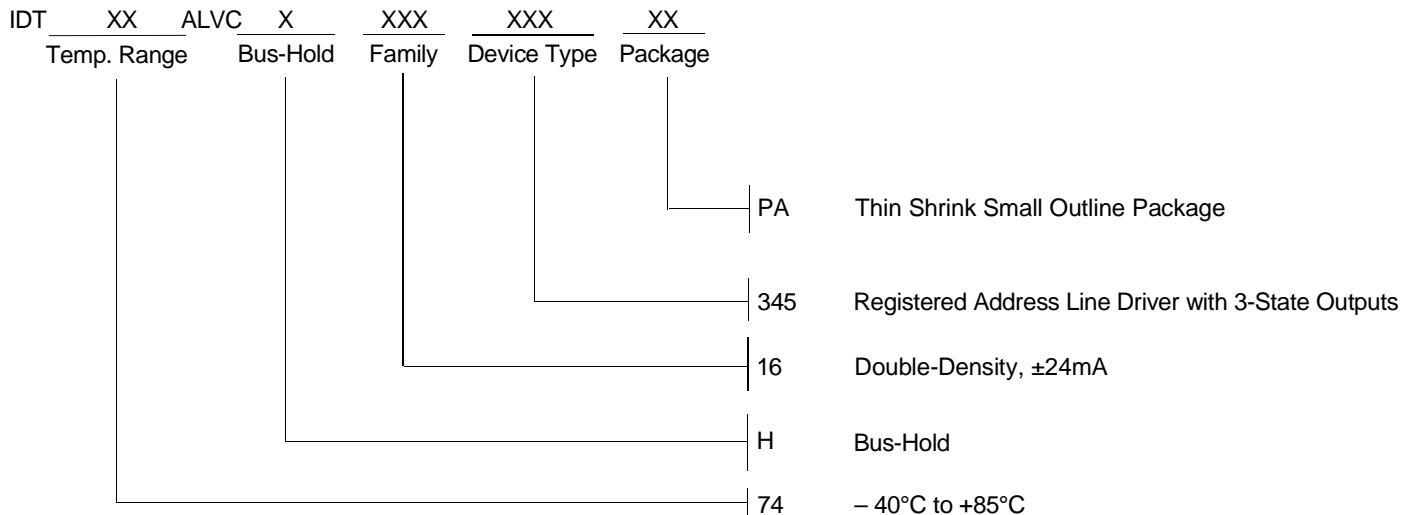
1. Diagram shown for input Control Enable-LOW and input Control Disable-HIGH.



Set-up, Hold, and Release Times



ORDERING INFORMATION



CORPORATE HEADQUARTERS
 2975 Stender Way
 Santa Clara, CA 95054

for SALES:
 800-345-7015 or 408-727-6116
 fax: 408-492-8674
www.idt.com

for Tech Support:
logichelp@idt.com
 (408) 654-6459